# REPORT DOCUMENTATION PAGE

Form Approved OM8 No. 2704-0188

14thering and maintaining the distainceded, and completion of information, including suggestions for recovery studyway. Suite 1204. Arlington, VA 22202-4302.	leting and reviewing the collection of in fucing this burden, to Washington Head and to the Office of Management and 8	formation. Send comments (e.g.) quarters Services, Directorate (s udget, Paperwork Reduction Pro	r information Operations and Heports, 1215 Jefferson ect (0704-0188), Washington, CC 20503.
1. AGENCY USE ONLY (Leave blank)	2. REPORT DATE	3. REPORT TYPE AN FINAL REPOR	O DATES COVERED
4. TITLE AND SUBTITLE			S. FUNDING NUMBERS
Tunable ELectrically-Pumped Rare-Earth-Doped Nitride Lasers			611007
Robert J. Feuerstein			61102F 2305/FS
Jacques I. Pa	nkove		
7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES)			AFOSR-TR-97
The Regents of the University of Colorado Campus Box 19			
Boulder, CO 80309-0019			0171
9. SPONSORING/MONITORING AGENCY	NAME(S) AND ADDRESS(ES)		10. SPONSORING/MONITORING AGENCY REPORT NUMBER
AFOSR - NE			
110 Duncan Avenue Room B115			F49620-95-1-0301
Bolling Air Force Base,	D.C. 20332-8080		
11. SUPPLEMENTARY NOTES			• • • • • • • • • • • • • • • • • • • •
12a. DISTRIBUTION / AVAILABILITY STATE	MENT		12b. DISTRIBUTION CODE
APPROVED FOR PUBLIC RELE	ASE: DISTRIBUTION (	INLIMITED	
	A. Yana	(PATOLIK	officerous <u>propri</u>
Abstract: This is the final relater sources. The report considered addresses the behavior of the fluorine. The Er luminescent room temperature), annealing concentration (over three order the successful detection of lutreatment following the ion is luminescence lifetime data where the pump wavelengths, but not pump wavelengths.	nsists of a number of pure rare earth erbium (Er) are properties were studied treatment (number of ders of magnitude), and aminescence in the 1550 mplantation of the Er are ersus Er density, pumper on (PLE) spectroscopy of to 77K and room temper in not all. A metal-insula duminescence measuren	ablications by the redoped into GaN, wied versus temperary anneals, duration, at the Er density. Comm (4113/2 - 4115/2) and co-dopant ions wavelength, and temperature, showed the utor-n-type diode strents showed weak	esearchers. The work with co-dopants oxygen and ture (10K, 77K, and up to and temperature), co-dopant dopants were essential to band. An annealing was also required. Photomperature are presented a range 770-1010 nm using usual thermal quenching for ructure also exhibited 1550 980 nm luminescence
14. SUBJECT TERMS			15. NUMBER OF PAGES
na ta	•	· . · ?	16. PRICE CODE
	ECURITY CLASSIFICATION 1 F THIS PAGE	9. SECURITY CLASSIFIC OF ABSTRACT	ATION 20. LIMITATION OF ABSTRACT
NSN 7540-01-280-5500	TIC QUALITY IIISPEĆK	md 3	Standard Form 298 (Rev. 2-89) Prescribed by ANSI Std. Z39-18 298-102

Final Report AFOSR Contract: F49620-95-I-0301 Tunable Electronically Pumped Rare Earth Doped Nitride Lasers

Robert J. Feuerstein, Jacques I. Pankove
Department of Electrical and Computer Engineering
University of Colorado
Boulder, CO 80309-425
303-492-7077 303-492-5470
robertf@colorado.edu pankove@schof.colorado.edu

#### Introduction

This is the final report for an AFOSR grant. The report consists of copies of the publications that resulted from this research. There is also an appendix listing all publications and presentations that resulted from this work. The list includes publications from the previous grant, of which this was a continuation of sorts. The work addresses the behavior of the rare earth erbium (Er) ion implanted into GaN, with co-dopants oxygen and fluorine. We are pleased to acknowledge our collaborator, Dr. F. Namavar of Spire Corporation for ion implantation and characterization of the GaN material.

The Er luminescence properties were studied versus temperature (10K, 77K, and up to room temperature), annealing treatment (number of anneals, duration, and temperature), co-dopant concentration (over three orders of magnitude), and the Er density. Co-dopants were essential to the successful detection of luminescence in the 1550 nm ( ${}^4I_{13/2} - {}^4I_{15/2}$ ) band. An annealing treatment following the ion implantation of the Er and co-dopant ions was also required [Journal papers 1,3]. Photo-luminescence lifetime data versus Er density, pump wavelength, and temperature are presented [Journal paper 4].

The GaN:Er,O material was studied with photo-luminescence excitation (PLE) spectroscopy. The signal was at the peak luminescence wavelength of 1539 nm and the pump scanned over the wavelength range 770-1010 nm using a tunable Ti:Sapphire laser. Measurements were performed at 77K and at room temperature. The results showed the usual thermal quenching for most pump wavelengths, but not all [Submitted paper 1]. A GaN:Er metal-insulator-n-type (MIN) diode structure also exhibited 1550 nm luminescence [Journal paper 2].

Cathodo-luminescence measurements showed weak 980 nm luminescence while the PLE measurements did not [Journal paper 5]. A review paper of the field of rare earth doped semiconductors is currently being revised [Submitted paper 2]. A copy of the accepted paper will be sent to the AFOSR following final revisions.

19970602 143

# Appendix I. Publications and Presentations

This appendix lists the papers and presentations by the student funded with the AASERT grant. It also includes the AASERT student's Ph.D. thesis title and some recent works submitted to journals.

## Journal Papers

- 1. J.T. Torvik, C.H. Qiu, R.J. Feuerstein, J.I. Pankove, F. Namavar, "Photo-, cathodo-, and electro-luminescence from erbium and oxygen co-implanted GaN," J. Appl. Phys. (May 1997).
- 2. J.T. Torvik, R.J. Feuerstein, J.I. Pankove, C.H. Qiu, F. Namavar, "Electro-luminescence from erbium and oxygen coimplanted GaN," Appl. Phys. Lett., 69(14), pp. 2098-2100 (1996).
- 3. C.H. Qiu, M.W. Leksono, J. Torvik, R.J. Feuerstein, J.I. Pankove, F. Namavar, "Cathodo-luminescence study of Er and Oxygen co-implanted Gallium Nitride thin films on Sapphire substrates," Appl. Phys. Lett. 66(5), pp. 564 (1995).

### Conference Papers

- 1. J.T. Torvik, R.J. Feuerstein, J.I. Pankove, F. Namavar, "Annealing study of erbium and oxygen implanted gallium nitride," Mat'ls Res. Soc. Symp. Vol. 422, pp. 199-204, MRS Pittsburgh, PA (1996). Ed.'s S. Coffa, A. Polman, R.N. Schwartz.
- 2. J.T. Torvik, C.H. Qiu, R.J. Feuerstein, J.I. Pankove, F. Namavar, "Luminescence at 1539 nm from Er and Oxygen implanted GaN." 1996 Conf. on Optoelectronic and Microelectronic Materials and Devices (COMMAD 96), Dec 9-11, 1996, Canberra, Australia.

#### Ph.D. Dissertation

Dr. John T. Torvik, "The Doping and Characterization of Erbium in Gallium Nitride."

### Submitted Works

- 1. J.T. Torvik, R.J. Feuerstein, C.H. Qiu, J.I. Pankove, F. Namavar, Photoluminescence excitation measurements on erbium implanted GaN," Submitted to J. Appl. Phys. April 1997.
- 2. J.T. Torvik, R.J. Feuerstein, W.A. Melton, J.I. Pankove, "Luminescence in Rare Earth Doped Semiconductors," Applied Physics Reviews, (currently incorporating reviewers comments).

# Conference, Workshop and Other Presentations

(by R.J. Feuerstein)

- 1. "Rare Earth doped semiconductors for interconnects," at the ISHM/IEPS Advanced Technology Workshop on Optoelectronics, Ojai, CA, invited paper, Feb. 21, 1995.
- 2. "Luminescence in Rare Earth Doped Semiconductors," Paper to URSI meeting, Boulder, CO, invited paper, Paper D1-3, Jan. 3, 1995.
- 3. "Cathodoluminescence in Erbium doped Gallium Nitride," at the European Quantum Electr. Conf., Amsterdam, Netherlands, August 28 Sept. 2, 1994.
- 4. "Luminescence in Er doped GaN," at the Rare Earth Doped Optoelectronic Materials Workshop, Hughes Laboratories, Malibu, CA, June 16-17, 1994.
- 5. "Erbium Doped Silicon for Optical Sources and Amplifiers," at the URSI meeting, Boulder, CO., Jan. 1994.
- 6. "Luminescence in Rare Earth Doped Semiconductors," at the National Institute of Standards and Technology, Boulder, CO., Nov. 12, 1993.
- 7. "Erbium Doped Silicon for Lasers and Amplifiers," to the Microwave Optics Seminar, Univ. of CO, Boulder, CO, March 2, 1993.

#### Submitted Works

- 1. J.T. Torvik, R.J. Feuerstein, C.H. Qiu, J.I. Pankove, F. Namavar, Photoluminescence excitation measurements on erbium implanted GaN," Submitted to J. Appl. Phys. April 1997.
- 2. J.T. Torvik, R.J. Feuerstein, W.A. Melton, J.I. Pankove, "Luminescence in Rare Earth Doped Semiconductors," Applied Physics Reviews, (currently implementing reviewers comments).